

**Notice of References Cited**

 Application/Control No.  
 10/007,421  
 Applicant(s)/Patent Under  
 Reexamination  
 MATSUMOTO ET AL.

 Examiner  
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**NON-PATENT DOCUMENTS**

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.